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## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2002/0120561 A1	08-2002	Chin et al.	705/38
	В	US-			
	O	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
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	1	US-			
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## FOREIGN PATENT DOCUMENTS

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## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Fabey, Michael. Brazil Cracks Down. Journal of Commerce; New York: Nov. 16, 1998. (3 pages)
	٧	Turner, Wayne C. et al. Introduction to Industrial and Systems Engineering, 3 <sup>rd</sup> ed. Prentice Hall, 1993. pages 520-521.
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

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